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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/663,279	KHATAMI ET AL.	
Examiner	Art Unit	
Gregory P. Hein	2188	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
711/103	2/1/2006	GPH
East Keyword Search - See attached	2/1/2006	GРН
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